TOSHIBA TB31206FN/AFN

TOSHIBA BI-CMOS INTEGRATED CIRCUIT SILICON MONOLITHIC

TB31206FN, TB31206AFN

PLL FREQUENCY SYNTHESIZER

FEATURES

• One packaging CH1/CH2 two systems prescaler and PLL.

Low operating power supply voltage

 $V_{CC} = 2.7 \sim 5.5 \text{ V}$

Low current consumption
 FN : I_{CC} = 16.5 mA (Typ.)

AFN : $I_{CC} = 14.5 \text{ mA (Typ.)}$

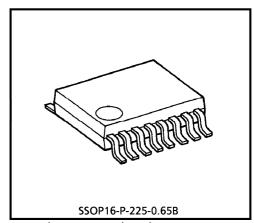
• Input frequency : $f_{IN} = 520 \sim 1100 \text{ MHz}$ • High input sensitivity : $V_{IN} = 92 \sim 107 \text{ dB} \mu\text{V}$

 Charge pump is constant current type, and is able to change output current by serial data

 Reference oscillation circuit is adopted circuit of bipolar, so getting the stable X'tal oscillation circuit

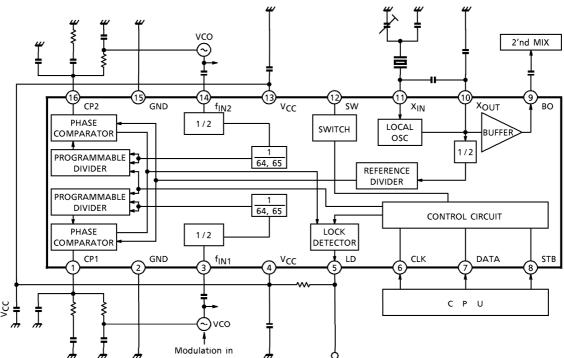
Available standby control in CH1 and CH2 independent of each other

• The very small package : SSOP16pin (0.65 mm pitch)



Weight: 0.07 g (Typ.)

BLOCK DIAGRAM



PIN FUNCTION (The values of resistor and capacitor are typical.)

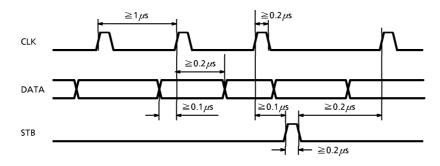
PIN	PIN	The values of resistor and capaci	INTERNAL FOLINGS FOR STORY				
No.	NAME	FUNCTION		INTERNAL EQUIVALENT CIRCUIT			
1	CP1	Output terminal of charge pump Charge pump is constant current	output circuit, and	VCC			
16	CP2	output current is varied by inpu	t serial data.	GND SINGLE STATE OF THE STATE O			
2	GND	GND Terminal.					
15	GND	GIVD TETTITION.		_			
3	f _{IN1}	Input terminal of RF oscillation s	ignal.	VCC			
14	f _{IN2}	·		GND GND			
4	Vcc	Power Supply Terminal.					
13	Vcc	. c. c. sapp.y . c. mina.					
5	LD	Output terminal of lock detector It is the open drain output.	5 200Ω				
12	SW	It is the open drain output.	When don't switch constant of loop filter, available				
6	CLK	Input terminal of clock.		6 1kΩ			
7	DATA	Input terminal of serial data.	Input the serial data for controlling IC.	7 8 4			
8	STB	Input terminal of strobe signal.		<i>m</i>			
9	во	Output terminal of buffer amplifier. The signal of local oscillation is output through the buffer amplifier.		Vcc			
10	X _{OUT}	Output terminal of local oscillati	on signal.	100Ω			
11	Χ _{IN}	Input terminal of local oscillation in case of external input, connecterminal.	9 500Ω 1kΩ GND				

DESCRIPTION OF FUNCTION AND OPERATION

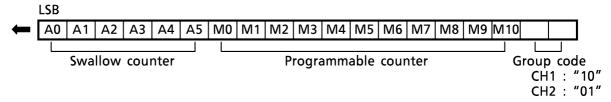
- 1. Entry of serial data
 - Serial data used to control the IC is input through three terminals, CLK, DATA and STB.
 - ① During the rise of a clock pulse, data is fed to the shift register in the IC in order from the LSB.
 - ② Upon the reception of all data, the strobe signal (STB) is made "H".
 - 3 After the situation of 2, the data stored in the shift register is transferred to the latch in the block selected by the group code, whereby the IC is controlled.
 - The three terminals, CLK, DATA and STB, contains Schmitt trigger circuits to prevent the data errors by noise, etc.
 - O Serial data group and group code
 - The IC has control divided into four groups so that they may be controlled independent of one another. Each group is identified by a two-bit group code attached at the data end.

CODE	ITEM
10	Number of divisions by CH1 programmable divider (f _{IN1})
01	Number of divisions by CH2 programmable divider (f _{IN2})
11	Number of divisions by reference divider (X _{IN})
00	Optional control

Serial data input timing



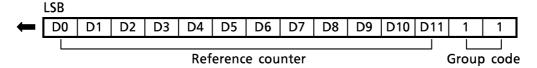
- 2. CHANNEL dividers (CH1, CH2)
 - These programmable dividers are composed of a half fixed divider, a 6bit swallow counter (6bit programmable divider), a 11bit programmable counter, and a two-modulars prescaler providing 64 and 65 divisions.
 - The strategy of a swallow counter is used to set high reference frequency.
 - Sending certain data to the swallow counter and the programmable counter allows the setting of any of 8064 to 262142 divisions (multiple of two).
 - The programmable counter and swallow counter are set by each channel. Each channel is specified by a group code.



$$\begin{cases} A = A0 + A1 \times 2^{1} + \cdots + A5 \times 2^{5} \\ M = M0 + M1 \times 2^{1} + \cdots + M10 \times 2^{10} \\ \text{Number of divisions} = 2 (64N + A) \\ 8064 \leq \text{Number of divisions} \leq 262142 \end{cases}$$

(EX) A Signal of 900MHz is entered into $f_{|N1}$, being divided into 25.0kHz step. (Reference frequency is 12.5kHz) $900\times10^6\div(25.0\times10^3\div2)=72000$ $72000=2\ (64N+A)$ $\therefore N=562,\ A=32$

- 3. Reference divider
 - This block generates the reference frequency for the PLL.
 - This reference divider is composed of a 12bit reference counter and a half fixed divider.
 - Sending certain data to the reference divider allows the setting of any of 6 to 8190 divisions (multiple of two).



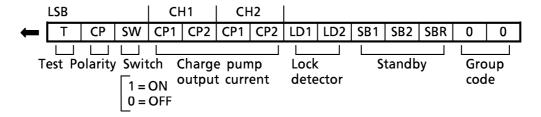
```
\begin{cases}
D = D0 + D1 \times 2^{1} + \dots D10 \times 2^{10} + D11 \times 2^{11} \\
\text{Number of divisions} = 2D \\
6 \le \text{Number of divisions} \le 8190
\end{cases}
```

(EX) With a 12.8MHz X'tal oscillator connected, being divided into 25.0kHz step. (Reference frequency is 12.5kHz) $12.8\times10^6\div(25.0\times10^3\div2)=1024$ 2D=1024

D = 512

4. Optional control

- The optional control below is available.
 - ① Test mode (Usually set up T = "0").
 - ② Control and polarity control of the charge pump output current for each channel.
 - 3 Output terminal for lock detector.
 - 4 Standby control of CH1, CH2 and reference divider.
 - 5 Control of filter switch.



T: Bit for test mode

CP : Switchover bit for charge pump output polarity

SW : Control bit for filter switch

CP1, 2 : Switchover bit for charge pump output current

LD1, 2: Control bit for lock detector output SB1, 2: Standby control bit for CH1, CH2

SRB : Standby control bit for reference divider

- Description of options including their control
 - ① Test mode (T)

Bit "T" is for test mode. In other than the test mode, set this bit at "0".

② Control of charge pump output current (CP1, CP2)

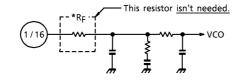
This IC uses a constant current output type charge pump circuit. Output current is varied by serial data "CP1" and "CP2".

CHARGE PUMP OUTPUT CURRENT

CONTR	OL BIT	CHARGE PUMP		
CP1	CP2	OUTPUT CURRENT		
0	0	± 100μA		
0	1	± 200μA		
1	0	± 400μA		
1	1	± 800μA		

High speed lock up is possible by switching charge pump output current.

(Note)



Charge pump output polarity (CP)

Bit "CP" can be reversed charge pump output polarity.

CHARGE PUMP OUTPUT POLARITY

СР	OUTPUT POLARITY
0	Normal
1	Reverse

3 Lock detector output

When phase comparator detects phase difference, LD terminal (pin 5) outputs "L". When phase comparator locks, LD terminal outputs "H". On standby, outputs "H". LD terminal output is controlled by "SB1", "SB2", "LD1" and "LD2".

	CONTR	OL BIT		- 5PIN OUTPUT		
SB1	SB2	LD1	LD2	JEIN OUTFUT		
		0	0	L		
0	0	0	1	CH2 only detect		
"		1	0	CH1 only detect	Logical m	
		1	1	CH1 * CH2	→ (AND) of	
		0	0	L	,, 5.	
0	1	0	1	Н		
"			1	0	CH1 only detect	About SB1,
			1	1	CH1 only detect	√0 : Norm
	0	0	0	L	1 : Stand	
,		0	1	CH2 only detect	∟ı : Stanc	
'		1	0	Н	1	
		1	1	CH2 only detect		
		0	0	L		
1		0	1	Н		
'	'	1	0	Н		
		1	1	Н		

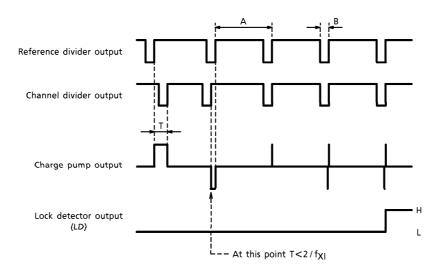
nultiplication CH1, CH2

SB2 bit

nal operation

dby

6 2002-03-29



 f_{XI} .. X_{IN} operating frequency (X'tal OSC)

T The time difference of the pulse between reference divider output and channel divider output. (Phase difference)

fpc .. Phase comparison frequency

$$A = \frac{Number of divisions by reference divider}{f_{XI}} (s) = \frac{1}{f_{PC}} (s)$$

$$B = 2 / f_{XI} (s)$$

When the situation that T is less than B (T<B) continues more than $3/fp_C$ (s), lock detector outputs "H".

4 Standby control (SB1, SB2, SBR)

Standby control by three bits (SB1, SB2, SBR).

Bits "SB1" and "SB2" do standby control of CH1, CH2. Bit "SBR" does standby control of reference divider.

	ONTROL BI	Т	STATE			
SB1	SB2	SBR	CH1	CH2	REFERENCE DIVIDER	
0	0	*	ON	ON	ON	h
0	1	*	ON	OFF	ON	Interlocking mode
1	0	*	OFF	ON	ON	
1	1	0	OFF	OFF	ON	— REFERENCE
1	1	1	OFF	OFF	OFF	DIVIDER ON

Note: * is don't care.

5 Filter switch control (SW)

Control of SW terminal by bit "SW".

This terminal is for switching constant of loop filter.

Output type of this terminal is open drain output. Switching the resistor of loop filter by this terminal with switching charge pump output current, high mode and normal mode can operate PLL by ideal braking factor.

When constant of loop filter don't change switch, available general output.

FILTER SWITCH CONTROL

SW	OUTPUT	
0	OFF	
1	ON	

5. X'tal oscillation circuit and buffer amplifier

This IC has a stable oscillation circuit composed of bipolar.

In case of the external input of reference frequency directly, use X_{IN} terminal (pin 11).

For the common use of X'tal of the X'tal oscillation circuit for the PLL and X'tal of the local oscillation to 2'nd MIX, output terminal of local oscillation signal with buffer amplifier (pin 9) may be used.

This terminal (pin 9) is provided with a buffer amplifier.

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Power Supply Voltage	Vcc	6	V
Power Dissipation	PD	560	mW
Operating Temperature	T _{opr}	- 30~85	°C
Storage Temperature	T _{stg}	- 55∼150	°C

ELECTRICAL CHARACTERISTICS

(Unless otherwise specified, $V_{CC} = 3.0V$, $Ta = 25^{\circ}C$)

CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION I		TYP.	MAX.	UNIT	
Operating Power Supply Voltage	Vcc	1		2.7	3.0	5.5	٧	
Operating Current Consumption : FN	laaa	1	CH1 CH2 operating	_	16.5	21.5	mΛ	
Operating Current Consumption: AFN	lccQ	'	CH1, CH2 operating	_	14.5	19.5	mA	
f _{IN} Operating	fIN1	1	$V_{\text{IN1}} = 92 \sim 107 \text{dB} \mu \text{V}$ *1	520	_	1100	N/111-	
Frequency	fIN2	1	$V_{IN2} = 92 \sim 107 dB \mu V$ *1	520	_	1100	MHz	
for Innut Consistivity	V _{IN1}	1	f _{IN1} = 520~1100MHz *1	92	_	107	dΒμV	
f _{IN} Input Sensitivity	V _{IN2}	1	f _{IN2} = 520~1100MHz *1	92	_	107		
X _{IN} Operating Frequency	fXI	1	$V_{XI} = 102 \sim 112 dB \mu V Sin-wave*1$	5	_	25	MHz	
X _{IN} Input Voltage	V _{XI}	1	f _{XI} = 5~25MHz	102	107	112	$dB\muV$	
Input Voltage	V _{IH}	_	STB, DATA, CLK	V _C C × 0.8	V _{CC}	5.7	V	
imput voitage	V _{IL}	_	STB, DATA, CLK	- 0.2	0	V _C C + 0.2	٧	
CLK Input Frequency	fCLK	_	CLK	_	_	1.0	MHz	
	I _{CP1}	1	"CP1" = 0, "CP2" = 0, $V_{CP} = 1.5V$	_	± 100	_		
Charge Pump Output	I _{CP2}	1	"CP1" = 0, "CP2" = 1, $V_{CP} = 1.5V$	_	± 200	_		
Current	I _{CP3}	1	"CP1" = 1, "CP2" = 0, $V_{CP} = 1.5V$	_	± 400	_	μ A	
	I _{CP4}	1	"CP1" = 1, "CP2" = 1, $V_{CP} = 1.5V$	_	± 800	_		
Charge Pump OFF Leak Current	CPOFF	1	Standby mode, V _{CP} = 1.5V	- 1.0	_	1.0	μΑ	

^{*1:} When input is terminated with 50 Ω .

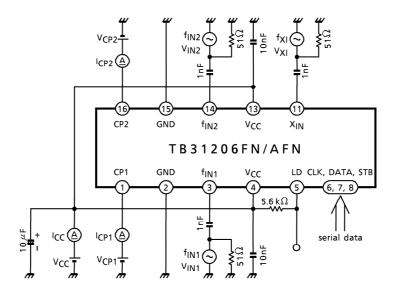
REFERENCE DATA (Typ.)

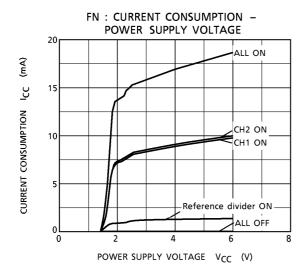
CH1	CHO	REFERENCE	CURRENT CO	UNIT		
СП	CH2	DIVIDER	FN	AFN	OIVII	
N	N	ON	16.5	14.5	mA	
N	S	ON	9.0	8.0	mA	
S	N	ON	9.0	8.0	mA	
S	S	ON	1.4	1.4	mΑ	
S	S	OFF	0	0	μ A	

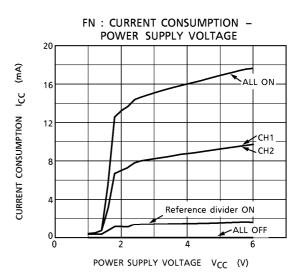
N: Normal operating

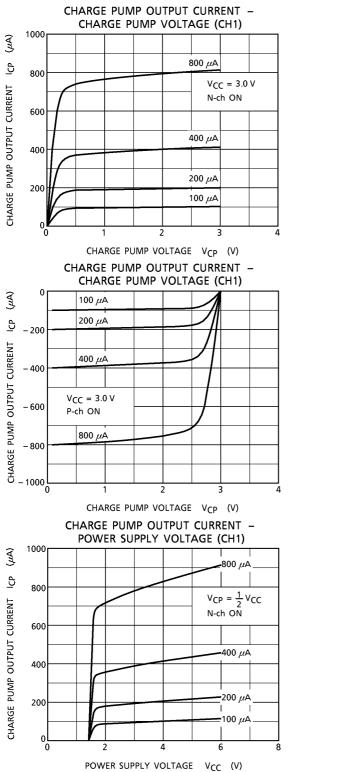
S: Standby mode

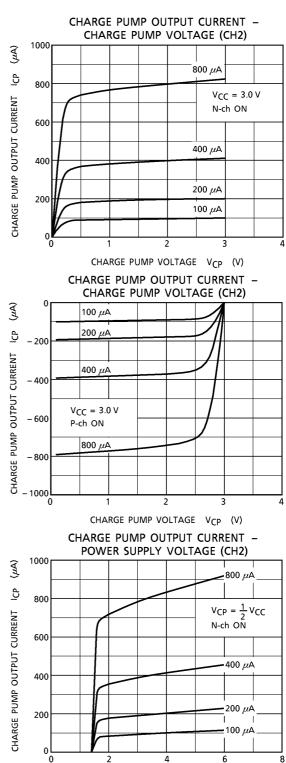
TEST CIRCUIT





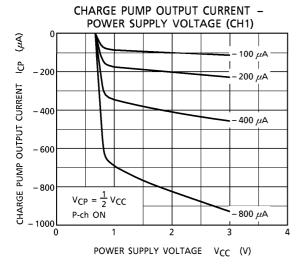


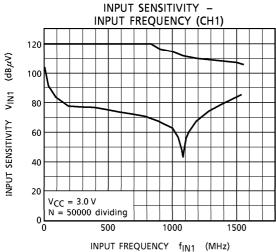


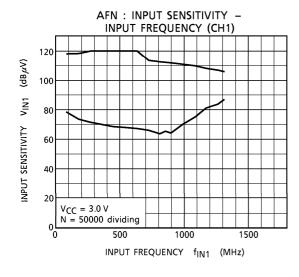


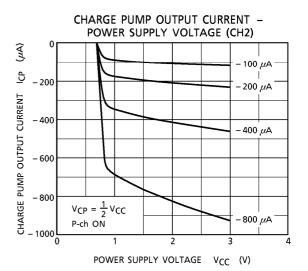
11 2002-03-29

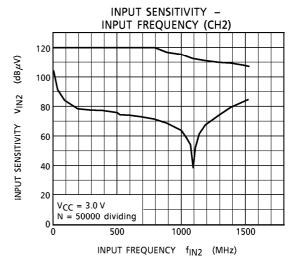
POWER SUPPLY VOLTAGE V_{CC} (V)

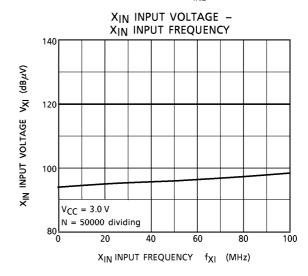




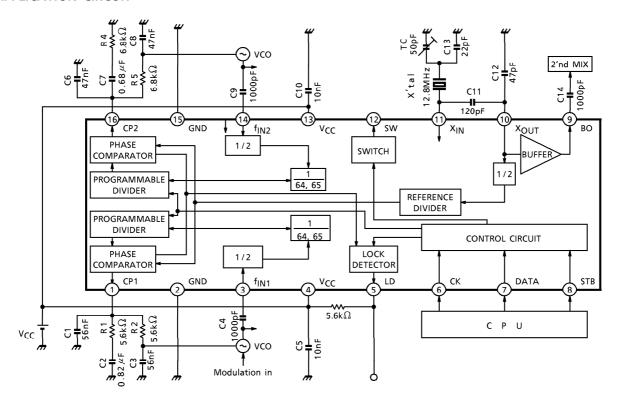








APPLICATION CIRCUIT



Set up conditions (E-TACS)

Frequency bandwidth ; 32.975MHz
 Frequency probability error ; ±1kHz

3. Lock up time ; 30ms (calculated value)

4. X'tal frequency (f_{XI}) ; 12.8MHz 5. Phase comparison frequency (f_{PC}) ; 12.5kHz 6. Charge pump current (I_{CP}) ; 800 μ A

TX (CH1)

·VCO frequency ; 888.5MHz (center)

·VCO conversion sensitivity ; 14MHz/V

RX (CH2)

·VCO frequency ; 978.5MHz (center)

·VCO conversion sensitivity ; 13MHz/V

PACKAGE DIMENSIONS SSOP16-P-225-0.65B Unit : mm 0.23TYP 0.23TYP 0.65 5.5MAX 5.0±0.2 0.45±0.2

Weight: 0.07 g (Typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- ◆ The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.